Search Notes				

Application/Control No.	Applicant(s)/Patent under Reexamination
10/541,166	KIM, HAE-IL
Examiner	Art Unit
David J. Walczak	3751

SEARCHED			
Class	Subclass	Date	Examiner
401	6, 7, 48, 88	6/21/2006	DW
16	430		
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